## Notice of References Cited Reexamination EASWAR ET AL. Examiner LUONG T NGUYEN Reexamination EASWAR ET AL. Page 1 of 1

Application/Control No.

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,463,177	10-2002	Li et al.	382/232
	В	US-5,790,878	08-1998	Anderson et al.	713/340
	С	US-6,104,430	08-2000	Fukuoka, Hiroki	348/231.6
	D	US-6,020,920	02-2000	Anderson, Eric C.	348/222.1
	E	US-6,154,493	11-2000	Acharya et al.	375/240.19
	F	US-6,195,026	02-2001	Acharya, Tinku	341/60
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-	·	·	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	a					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	NON-ATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	υ							
	٧							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under